

SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS PRODUCT SPECIFICATION 規格書

CUSTOMER: (客戶):志盛翔 DATE: (日期):2018-04-25

CATEGORY (品名)	: ALUMINUM ELECTROLYTIC CAPACITORS
DESCRIPTION (型号)	: RD 450V150μF(φ18X45)
VERSION (版本)	: 01
Customer P/N	:
SUPPLIER	:

SUPPI	JER		CUST	OMER
PREPARED (拟定)	CHECKED (审核)	AP	PROVAL (批准)	SIGNATURE (签名)
孟庆庆	刘渭清			

ELECTROLYTIC CAPACITOR SPECIFICATION RD SERIES

		SPECIFIC			1	ALTERN	ATION HI	STORY
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						<u> </u>		Approve
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ble 1 Product		s and Cha		ristics d±0.05		β 0.5	0.5	β ΦD<20: lf it is flat ru	bber, ther	: a=2.0 D≥20 : β =			flat ru
				d±0.05			0.5	β ΦD<20: lf it is flat ru	$\beta = 0.5; \Phi I$ bber, then	: a=2.0 D≥20 : β =	=1.0		flat rul
				d±0.05			0.5	β ΦD<20: lf it is flat ru	$\beta = 0.5; \Phi I$ bber, then	D≥20:β=			flat rul
						-1		surface.			ılge fr	om the	
	SAMXON	WV	Cap.	Cap. tolerance	Temp.	tan δ (120Hz ,	Leakage Current	Max Ripple Current at 105℃	Load lifetime		ension (mm)		Slee
	Part No.	(Vdc)	(µF)		range(℃)	20°C)	(µA,2min)	100KHz (mA rms)	(Hrs)	D×L	F	фd	ve
1 ERD157M	/I2WL45RR**P	450	150	-20%~+20%	-25~105	0.20	1375	1622	10000	18X45	7.5	0.8	PET

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1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

Part Number System 2. 4 5 6 7 89 101112 1314 123 1516 17 тс Ρ EGS 1 5 D11 S 0 м 1 н TOL SAMXON SLEEVE PRODUCT LINE MATERIAL SERIES CAPACITANCE VOLTAGE CASE SIZE TYPE Cap(MFD) Tolerance (%) Code Voltage (W.V.) Code Code Case Size Feature Code SAMXON Product Li ries ESM EKF ESS EKS EGS EKM EKG EOM EZM EZS 0D (4) Co 3 B 5 1 4 C 5 D 3 E RR For internal use only Radial bulk 0.1 104 ± 5 J 2.5 0E (The product lines 4 0G we have H.A.B.C.D. Ammo Taping 0.22 224 6.3 OJ к E,M or 0,1,2,3,4,5,9) ±10 0K 8 0.33 334 2.0mm Pitch тτ 10 1A ±15 L JV4AK7L8MN 12.5 1B 2.5mm Pitch τu 0.47 474 1C 16 EG м 1D ±20 20 105 3.5mm Pitch тν Sleeve Material Co FG 1 46 46.5 18 18.5 20 22 ? EGE 25 1E PET Р 11 5.0mm Pitch тс 30 2.2 225 Ν ±30 32 13 ERS ERF ERL ERR Lead Cut & Form 35 3.3 335 1V -40 w 22 25 30 34 35 40 42 45 40 1G OP WQ R 46S T U 8X Z СВ-Туре СВ 4.7 475 42 1M -20 0 А FR 50 1H ERE ERD ERH EBD СЕ-Туре CE 10 106 57 1L -20 +10 С 63 1J HE-Type HE 22 226 71 **1**S 51 3.5 76 80 ER. 75 1**T** 6 ERE ERC EFA ENP -20 +40 × KD-Type ĸD 336 33 80 1K 85 1R 90 100 -20 +50 FD-Type FD s Z Costing Ex 454 05 7 77 11 11 11 12 12 12 12 12 12 12 12 12 13 13 13 13.5 1C 20 20.5 2' 29.5 7 30.7 75 47 476 90 19 ENH ERV ERV ELP EAP EOP 100 2A -10 0 ЕН-Туре EΗ в 107 100 120 20 125 2B PCB Termial -10 +20 220 227 v 150 2Z 160 2C sw 330 337 -10 +30 Q 180 2P 200 2D Snap-in SX EKP EEP 470 477 -10 +50 215 22 т EFP ESP 220 2N 1C 20 25 2J 30 3A 35 3E sz 2200 228 -5 +10 230 23 Е EVP EGP EWR EWU EWT EWS EWF EWS EWH EWL EWB 250 2E Lug SG 22000 229 -5 +15 275 2Т F 05 300 21 33000 339 310 2R -5 +20 3 G 06 315 2F 50 80 1L 1K 1M 1P 47000 479 330 2U 0 +20 R Т5 2V 350 100000 10T Screw 360 2X 0 +30 0 т6 VNS 375 2Q 150000 15T 40 50 55 10 1R 1E 1S 1F 1T 1U 0 +50 385 2Y I. D5 400 2G 220000 22T +5 +15 2M z 420 D6 VZS 450 2W 330000 ззт +5 D 500 2H 1000000 550 25 10M +10 +50 26 Y 600 2J 1500000 15M 630 +10+30 н 2200000 22M 3300000 33M 5

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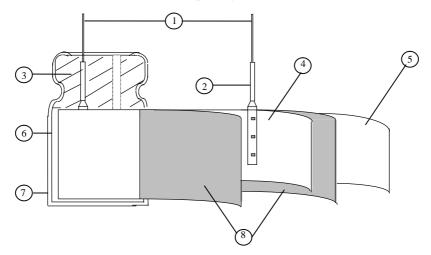
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3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature	:15°C to 35°C
Relative humidity	: 45% to 85%
Air Pressure	: 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature	$: 20^{\circ}C \pm 2^{\circ}C$
Relative humidity	: 60% to 70%
Air Pressure	: 86kPa to 106kPa

Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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Tabl	ITEM				PE	RFORM	IANCF	2				
	Rated voltage (WV)				1 12			-				
4.1		WV (V.DC)	160	200	220	250	350	400	420	450		
	Surge voltage (SV)	SV (V.DC)	200	250	270	300	400	450	470	500		
4.2	Nominal capacitance (Tolerance)	Measuring F Measuring V Measuring T < Criteria >	$<$ Condition>Measuring Frequency: 120Hz±12HzMeasuring Voltage: Not more than 0.5VrmsMeasuring Temperature: $20\pm2^{\circ}$ C $<$ Criteria>Shall be within the specified capacitance tolerance.									
4.3	Leakage current	<condition></condition> Connecting the capacitor with a protective resistor $(1k \Omega \pm 10 \Omega)$ in series for minutes, and then, measure Leakage Current. <criteria></criteria> Refer to Table 1										
4.4	tan δ	<condition> See 4.2, Norm Capacitance, for measuring frequency, voltage and temperature.<criteria> Refer to Table 1</criteria></condition>										
4.5	Terminal strength	<condition> Tensile Str Fixed the c seconds. Bending Str Fixed the ca 90° within 2 seconds. Diamet 0.5r Over 0. <criteri No notic</criteri </condition>	ength c apacito apacito 2~3 sec er of le nm and 5mm to a >	or, appl of Term r, applie conds, a ead wire <u>1 less</u> o 0.8mm	ied force ninals. ed force nd then e	to bent it bent it Fensile : (kg 5 (0 10 (:	the terr for 90 ^c force N (f) .51) 1.0)	ninal (1 ' to its o	~4 mm original Bendin (I 2.5 5 (from the position g force (cgf) (0.25) (0.51)	e rubb n with N	

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		<condition></condition>	Tosting Tar	oroturo (°C)		Tim	9	
			Testing Temp 20±		Time to reach thermal equilibrium		hairma	
		1					-	
		2	-40(-25 20±	,	Time to re		-	
		3	105		Time to re		-	
		4			Time to re			
			20土	2	Time to re	ach thern	iai equili	onum
		<criteria></criteria>		a a gran d'a h a l 1	ha within 1	-200/		
			c, capacitance m inal value at +2			20%		
	Temperature	•	ll be within the		4.4			
1.0	characteristi		ge current meas			8 times of	f its spec	ified value
4.6	cs		, tan δ shall be				ins spee	
		-	kage current sha				le.	
		c. At -25℃,	impedance (Z)	ratio shall no	t exceed the	value of	the follo	wing
		table:						
		Working	voltage (V)	160 200) 250	350	400	450
			C/Z-+20°C	3 3	3	5	5	6
		Conditions						
		<condition> According to I</condition>	EC60384-4No.4	4.13 methods.	The capacit	tor is stor	ed at a te	mperature
		According to II	EC60384-4No.4 n DC bias voltas		-			-
		According to II $105^{\circ}C \pm 2$ with	EC60384-4No.4 h DC bias voltag	ge plus the rate	ed ripple cu	rrent for '	Table 1 .	(The sum
		According to II 105°C ±2 with DC and ripple product should	h DC bias voltage peak voltage be tested after	ge plus the rate shall not exce 16 hours recov	ed ripple cu eed the rate	rrent for ' ed workin	Table 1 . ng voltag	(The sum ge) Then
	Load	According to II 105°C ±2 with DC and ripple product should result should m	h DC bias voltage	ge plus the rate shall not exce 16 hours recov	ed ripple cu eed the rate	rrent for ' ed workin	Table 1 . ng voltag	(The sum ge) Then
4.7	life	According to II 105°C ± 2 with DC and ripple product should result should m <criteria></criteria>	h DC bias voltage peak voltage be tested after neet the following	ge plus the rate shall not exce 16 hours recover ng table:	ed ripple cu eed the rate vering time	rrent for ' ed workin at atmosp	Table 1 . ng voltag	(The sum ge) Then
4.7		According to II 105°C ± 2 with DC and ripple product should result should m <criteria></criteria> The characteri	h DC bias voltag peak voltage be tested after neet the followin stic shall meet t	ge plus the rate shall not exce 16 hours recover ng table: he following	ed ripple cu eed the rate vering time requirement	rrent for ' ed workin at atmosp	Table 1 . ng voltag	(The sum ge) Then
4.7	life	According to II 105°C ±2 with DC and ripple product should result should m <criteria></criteria> The characteri Leakage	h DC bias voltage peak voltage be tested after neet the following stic shall meet t current	ge plus the rate shall not exce 16 hours recover ng table: he following to Value in 4.	ed ripple cu eed the rate vering time requirement 3 shall be sa	rrent for ' ed workin at atmosp ats. atisfied	Table 1 . ng voltag	(The sum ge) Then
4.7	life	According to II $105^{\circ}C \pm 2$ with DC and ripple product should result should m <criteria></criteria> The characteri Leakage Capacita	h DC bias voltag peak voltage be tested after neet the followin stic shall meet t	ge plus the rate shall not exce 16 hours record ng table: he following to Value in 4. Within ± 2	ed ripple cu eed the rate vering time requirement 3 shall be sa 0% of initi	rrent for ' ed workin at atmosp ats. atisfied al value.	Table 1 . ng voltag oheric cor	(The sum ge) Then nditions. T
4.7	life	According to II $105^{\circ}C \pm 2$ with DC and ripple product should result should m <criteria></criteria> The characteri Leakage Capacita tan δ	h DC bias voltag peak voltage be tested after neet the followin stic shall meet t current ance Change	ge plus the rate shall not exce 16 hours recover ing table: the following the Value in 4. Within ± 2 Not more the Not more the	ed ripple cu eed the rate vering time requirement 3 shall be sa 0% of initi han 200% o	rrent for ' ed workin at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp	Table 1 . ng voltag oheric con	(The sum ge) Then nditions. T
4.7	life	According to II $105^{\circ}C \pm 2$ with DC and ripple product should result should m <criteria></criteria> The characteri Leakage Capacita	h DC bias voltag peak voltage be tested after neet the followin stic shall meet t current ance Change	ge plus the rate shall not exce 16 hours record ng table: he following to Value in 4. Within ± 2	ed ripple cu eed the rate vering time requirement 3 shall be sa 0% of initi han 200% o	rrent for ' ed workin at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp at atmosp	Table 1 . ng voltag oheric con	(The sum ge) Then nditions. T
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4.7	life	According to II $105^{\circ}C \pm 2$ with DC and ripple product should m < Criteria> The characteri Leakage Capacita tan δ Appeara Condition> The capacitors a 1000+48/0 hou	h DC bias voltage peak voltage be tested after neet the followin stic shall meet t current ance Change ance are then stored w urs. Following th	ge plus the rate shall not exce 16 hours record ng table: he following the Value in 4. Within ± 2 Not more the There shall with no voltage his period the	ed ripple cu eed the rate vering time requirement <u>3 shall be sa</u> <u>0% of initi</u> han 200% o be no leaka e applied at capacitors	rrent for ' ed workin at atmosp at atmosp atisfied al value. f the spec age of ele a temper shall be r	Table 1. ng voltag oheric con cified val ctrolyte. ature of 1 emoved 1	(The sum ge) Then additions. T ue. $05\pm2^{\circ}C$ from the t
4.7	life test	According to II $105^{\circ}C \pm 2$ with DC and ripple product should m < Criteria> The characteri Leakage Capacita tan δ Appeara Condition> The capacitors a 1000+48/0 how chamber and b	h DC bias voltage peak voltage is be tested after if neet the followin stic shall meet the current ance Change ance are then stored works. Following the pe allowed to sta	ge plus the rate shall not exce 16 hours record ng table: he following the Value in 4. Within ±2 Not more the There shall with no voltage his period the abilized at root	ed ripple cu eed the rate vering time <u>requirement</u> 3 shall be sa 0% of initi han 200% o be no leaka e applied at capacitors om tempera	rrent for ' ed workin at atmosp at atmosp atisfied al value. f the spec- age of ele a tempera shall be r ture for 4	Table 1 . ng voltag oheric con cified val ctrolyte. ature of 1 removed 1 4~8 hour	(The sum ge) Then inditions. The ue. $05\pm2^{\circ}C$ from the to rs. Next the
	life test Shelf	According to II $105^{\circ}C \pm 2$ with DC and ripple product should result should m <criteria></criteria> The characteri Leakage Capacita tan δ Appeara <condition></condition> The capacitors a 1000+48/0 how chamber and b shall be conne	h DC bias voltage peak voltage be tested after in neet the following stic shall meet the current ance Change ance are then stored works. Following the pe allowed to stic cted to a series	ge plus the rate shall not exce 16 hours recover ing table: the following in Value in 4. Within ±2 Not more the There shall with no voltage his period the abilized at roos s limiting resi	ed ripple cu eed the rate vering time requirement 3 shall be sa 0% of initi han 200% o be no leaka e applied at capacitors om tempera stor(1k±10	rrent for ' ed workin at atmosp at atmosp atisfied al value. f the spect age of ele a temperative shall be r ature for 4 00Ω) with	Table 1 . ng voltag oheric con cified valic ctrolyte. ature of 1 emoved 1 4~8 hour th D.C. r	(The sum ge) Then additions. The ue. $05\pm2^{\circ}C$ from the to rs. Next the rated volta
4.7	life test Shelf life	According to II $105^{\circ}C \pm 2$ with DC and ripple product should m <criteria></criteria> The characteri Leakage Capacita tan δ Appeara <condition></condition> The capacitors a 1000+48/0 how chamber and b shall be conne applied for 30m	h DC bias voltage peak voltage is be tested after is neet the followin stic shall meet t e current ance Change ance are then stored w urs. Following the allowed to sta cted to a series nin. After which	ge plus the rate shall not exce 16 hours recover ing table: the following in Value in 4. Within ±2 Not more the There shall with no voltage his period the abilized at roos s limiting resi	ed ripple cu eed the rate vering time requirement 3 shall be sa 0% of initi han 200% o be no leaka e applied at capacitors om tempera stor(1k±10	rrent for ' ed workin at atmosp at atmosp atisfied al value. f the spect age of ele a temperative shall be r ature for 4 00Ω) with	Table 1 . ng voltag oheric con cified valic ctrolyte. ature of 1 emoved 1 4~8 hour th D.C. r	(The sum ge) Then additions. The ue. $05\pm2^{\circ}C$ from the the rs. Next the rated volta
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	life test Shelf life	According to II $105^{\circ}C \pm 2$ with DC and ripple product should m <criteria></criteria> The characteri Leakage Capacita tan δ Appeara <condition></condition> The capacitors a 1000+48/0 how chamber and b shall be conne applied for 30m	h DC bias voltage peak voltage is be tested after is neet the followin stic shall meet t e current ance Change ance are then stored w urs. Following the allowed to sta cted to a series nin. After which	ge plus the rate shall not exce 16 hours recover ing table: the following in Value in 4. Within ±2 Not more the There shall with no voltage his period the abilized at roos s limiting resi	ed ripple cu eed the rate vering time requirement 3 shall be sa 0% of initi han 200% o be no leaka e applied at capacitors om tempera stor(1k±10	rrent for ' ed workin at atmosp at atmosp atisfied al value. f the spect age of ele a temperative shall be r ature for 4 00Ω) with	Table 1 . ng voltag oheric con cified valic ctrolyte. ature of 1 emoved 1 4~8 hour th D.C. r	(The sum ge) Then additions. The ue. $05\pm2^{\circ}C$ from the the rs. Next the rated volta

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		<criteria></criteria>	
			meet the following requirements.
	Shelf	Leakage current	Value in 4.3 shall be satisfied
4.8	life	Capacitance Change	Within $\pm 20\%$ of initial value.
т.0	test	tan δ	Not more than 200% of the specified value.
	lest	Appearance	There shall be no leakage of electrolyte.
		Remark: If the capacitors are	e stored more than 1 year, the leakage current may
		increase. Please apply voltag	e through about 1 k Ω resistor, if necessary.
			the capacitor connected with a $(100\pm50)/C_R$ (k Ω) resistor.
		followed discharge of 5 min	
		The test temperature shall	
		C _R :Nominal Capacitance (
		<criteria></criteria>	r •)
4.9	Surge	Leakage current	Not more than the specified value.
	test	Capacitance Change	Within $\pm 15\%$ of initial value.
		$\tan \delta$	Not more than the specified value.
			There shall be no leakage of electrolyte.
		Appearance Attention:	There shall be no leakage of electrolyte.
			age at abnormal situation only. It is not applicable to such
		over voltage as often applied	
		<condition></condition>	
4.10	Vibration test	perpendicular directions. Vibration frequency ra Peak to peak amplitud Sweep rate Mounting method: The capacitor with diameter in place with a bracket. 4mm or les	e : 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute greater than 12.5mm or longer than 25mm must be fixed Within 30°
		<criteria> After the test, the follow</criteria>	To be soldered
		After the test, the follow	ing items shall be tested: No intermittent contacts, open or short
			ing items shall be tested: No intermittent contacts, open or short circuiting. No damage of tab terminals or
		After the test, the follow	ring items shall be tested: No intermittent contacts, open or short circuiting. No damage of tab terminals or electrodes.
		After the test, the follow Inner construction	ing items shall be tested: No intermittent contacts, open or short circuiting. No damage of tab terminals or electrodes. No mechanical damage in terminal. No leakage
		After the test, the follow	ring items shall be tested: No intermittent contacts, open or short circuiting. No damage of tab terminals or electrodes.

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	· · · · · · · · · · · · · · · · · · ·						1
		<condition></condition>					
		The capacitor shall be		•	onditions	:	
		Soldering temperatu	ire	: 245±3°C			
	C = 1.4 = 1.1114	Dipping depth		: 2mm			
4.11	Solderability	Dipping speed		: 25±2.5mm/	S		
	test	Dipping time		: 3±0.5s			
		<criteria></criteria>					
		Coating quality		A minimum	of 95% c	of the surfac	e being
				immersed			
		<condition></condition>					
		Terminals of the ca	pacitor shall	be immersed in	to solder	bath at	
		260 ± 5 °C for 10 ± 1	-		-		mm from the
					0 500010	5 10 1.5 2.0	initi from the
	Direct	body of capacitor.	hall ha laft w	don the normal	tomporor	ure and not	malhumidity
4.12	Resistance to solder heat	Then the capacitor for 1~2 hours befor			temperat	ure and not	mainumulty
4.12	test	<criteria></criteria>					
	0.51	Leakage current	Not	nore than the s	pecified	value.	-
		Capacitance Char		in $\pm 10\%$ of i			\neg
		$\tan \delta$		nore than the s			\neg
		Appearance		e shall be no le			
		<condition></condition>					
		Temperature Cycle		nethoda conce	itor shall	he placed :	n an oven the
		According toIEC60 condition accordin		nemous, capac	noi silall	be placed I	in all ovell, the
			Temperature	I	т	ime	
		(1)+20℃	remperature		≤3		
						Minutes	
	Change of	(2)Rated low tem	-			Minutes	
4.13	temperature	(3)Rated high tem		5°C)	30 ± 2	Minutes	
	test	(1) to (3)=1 cycle	, total 5 cycle				
		<criteria></criteria>	1 11 (C 11 ·			
		The characteristic					
		Leakage current		ore than the sp			
		tan δ		ore than the sp			
		Appearance	There	shall be no lea	kage of e	lectrolyte.	
		<condition></condition>					
		Humidity Test:		_		_	
		According to IEC60		-			
		be exposed for 500		-			
		$40\pm2^{\circ}$ C, the charac	teristic chang	e shall meet the	e followii	ng requiren	ent.
	Dec 1						
4.14	Damp heat	<criteria></criteria>	_				-, I
	test	Leakage current		e than the spec		e.	4
		Capacitance Chang		20% of initia			
		tan δ	Not mor	e than 120% of	f the spec	ified value.	
		Appearance	There sh	all be no leaka	ge of elec	ctrolyte.	
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4.15	Vent test	<condition> The following test only approximation with vent. D.C. test The capacitor is connected current selected from below <table 3=""> Diameter (mm) DC 22.4 or less Over 22.4</table></condition>	with its p v table is a <u>Current (A</u> 1 10 no dange	olarity revenues of the second	ersed to a I	DC power sou	rce. Then a
4.16	Maximum permissible (ripple current)	<condition> The maximum permissible at 120Hz and can be apple Table-1 The combined value of D rated voltage and shall not Frequency Multipliers: Coefficient (Hz) Cap. (µ F) 1~5.6 6.8~180 220~</condition>	lied at max	kimum oper e and the pe	rating temp	erature	exceed the

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5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-OA-072).

	Substances
	Cadmium and cadmium compounds
Heavy metals	Lead and lead compounds
	Mercury and mercury compounds
	Hexavalent chromium compounds
	Polychlorinated biphenyls (PCB)
Chloinated	Polychlorinated naphthalenes (PCN)
organic	Polychlorinated terphenyls (PCT)
compounds	Short-chain chlorinated paraffins(SCCP)
	Other chlorinated organic compounds
	Polybrominated biphenyls (PBB)
Brominated	Polybrominated diphenylethers(PBDE) (including
organic	decabromodiphenyl ether[DecaBDE])
compounds	Other brominated organic compounds
Tributyltin comp	oounds(TBT)
Triphenyltin com	npounds(TPT)
Asbestos	
Specific azo com	npounds
Formaldehyde	
Beryllium oxide	
Beryllium copp	er
Specific phthalat	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)
Hydrofluorocarb	on (HFC), Perfluorocarbon (PFC)
Perfluorooctane	sulfonates (PFOS)
Specific Benzotr	iazole

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Attachment: Application Guidelines

1.Circuit Design

- 1.1 Operating Temperature and Frequency Electrolytic capacitor electrical parameters are normally specified at 20 °C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.
- (1) Effects of operating temperature on electrical parameters
 - a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
 - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
 - a) At higher frequencies capacitance and impedance decrease while tand increases.
 - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).
- 1.2 Operating Temperature and Life Expectancy See the file: Life calculation of aluminum electrolytic capacitor
- 1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

(1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

- 1.4 Using Two or More Capacitors in Series or Parallel
- (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

- 1.5 Capacitor Mounting Considerations
- (1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

 $\phi 6.3 \text{-} \phi 16 \text{mm:} 2 \text{mm minimum, } \phi 18 \text{-} \phi 35 \text{mm:} 3 \text{mm minimum, } \phi 40 \text{mm or greater:} 5 \text{mm minimum.}$

- (5) Clearance for Seal Mounted Pressure Relief Vents
 - A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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 (6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite. (7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short. (8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification.
1.6 Electrical Isolation of the Capacitor Completely isolate the capacitor as follows.
 Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.
1.7 The Product endurance should take the sample as the standard.
1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.
1.9 Capacitor Sleeve The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor.
The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.
CAUTION! Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.
 2.Capacitor Handling Techniques 2.1 Considerations Before Using (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment. (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about 1kΩ. (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately 1kΩ. (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors. (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.
 2.2 Capacitor Insertion Verify the correct capacitance and rated voltage of the capacitor. Verify the correct polarity of the capacitor before inserting. Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals. Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor. For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.
 2.3 Manual Soldering (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less. (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal. (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads. (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.
2.4 Flow Soldering(1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.(2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.(3) Do not allow other parts or components to touch the capacitor during soldering.

2.5 Other Soldering Considerations Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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- 2.6 Capacitor Handling after Solder
- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning
- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60° C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result.
- Xylene : deterioration of the rubber seal could result.
- Acetone : removal of the ink markings on the vinyl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

3. Precautions for using capacitors

3.1 Environmental Conditions

- Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures.
- If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.
 - If electrolyte or gas is ingested by month, gargle with water.
 - If electrolyte contacts the skin, wash with soap and water.

5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000Ω , current limiting resistor for a time period of 30 minutes . If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions



The capacitor shall be not use in the following condition:

(1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.

(2) Direct contact with water, salt water, or oil.

(3) High humidity conditions where water could condense on the capacitor.

(4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.

(5) Exposure to ozone, radiation, or ultraviolet rays.

(6) Vibration and shock conditions exceeding specified requirements.

6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise).

Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

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